

MMC controllers for ultra low harmonic distortion

EnergyChord

July 2nd, 2014

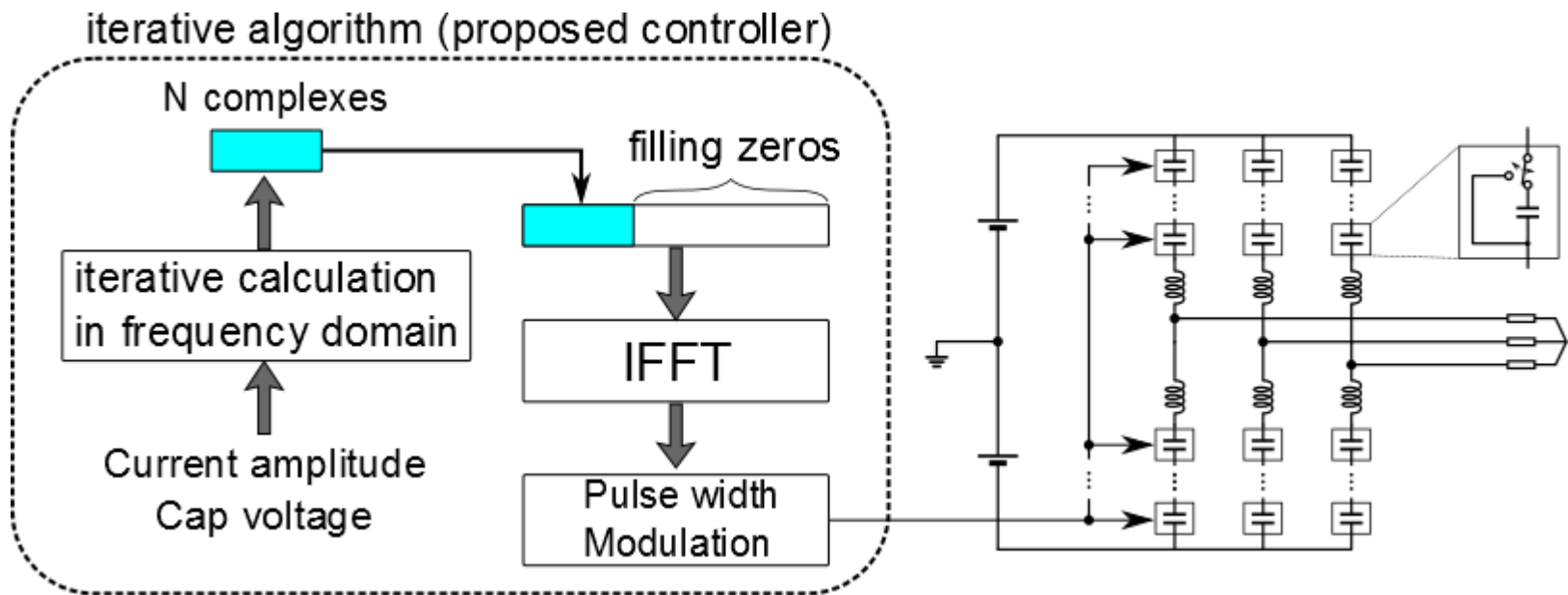
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Basic approach

- Comprehensive study on the behavior of MMCs in **Frequency domain**.
- **Iterative algorithm** to obtain control signals as fast as possible.
- Controller **based on FFT**, that's readily available in digital domain.

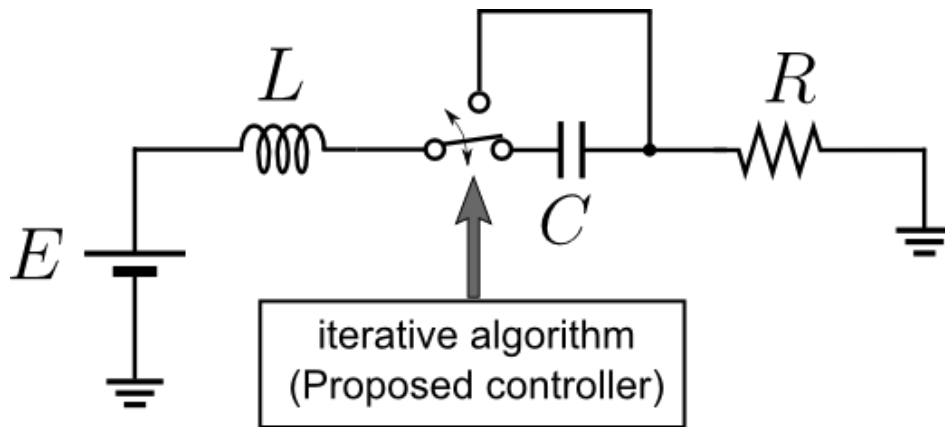
Proposed MMC controller



- The proposed system described above minimizes the harmonic distortion of the output current **by adjusting the higher harmonics in control signals**.
- It adopts an iterative algorithm in finding the optimum control signals.
- $N < 16$ has been found to be enough for most of cases.

--- Test circuits ---

Test circuit I (LCR series circuit)



$$E = 100 \quad [\text{V}]$$

$$L = 0.5 / 1.0 / 2.0 \quad [\text{mH}]$$

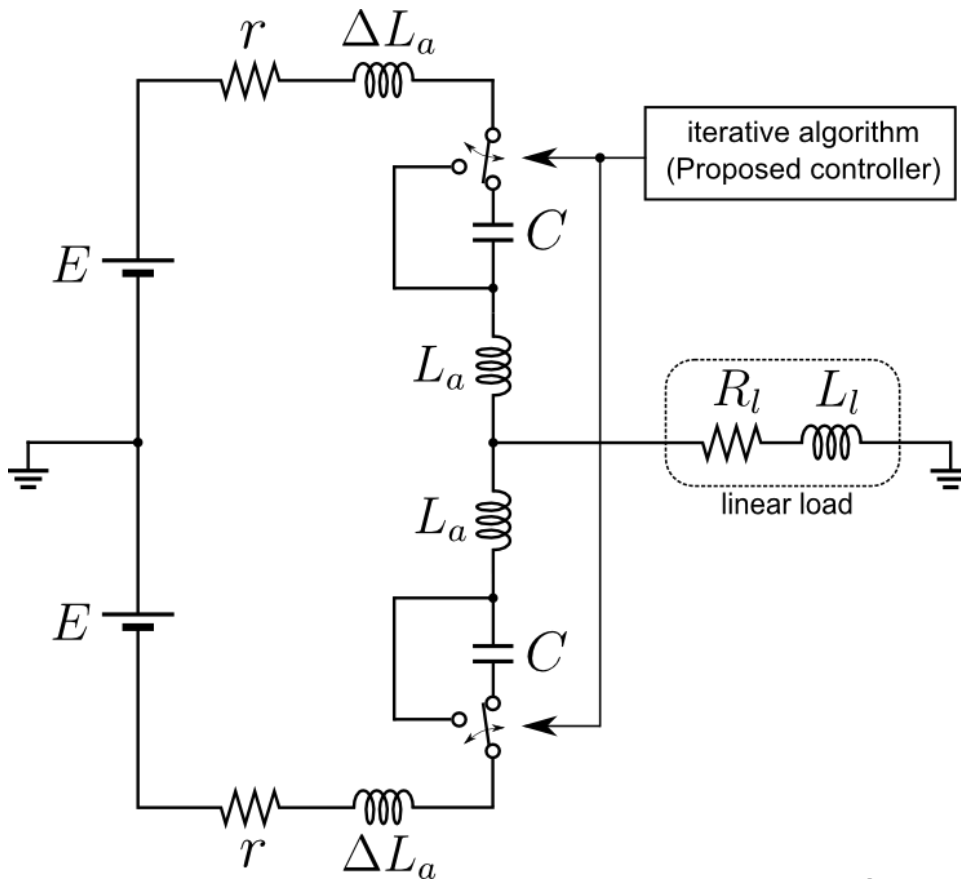
$$C = 0.5 / 1.0 / 2.0 \quad [\text{mF}]$$

$$R = 10 \quad [\Omega]$$

$$f = 50 \quad [\text{Hz}]$$

- The simplest conceivable circuit for the control
- continuous-time approximation to check THD
- This simple study is applicable to controls of other complicated MMC circuits.

Test circuit II (The simplest MMC)



$$E = 100 \quad [\text{V}]$$

$$L_a = 0.5 / 1.0 / 2.0 \quad [\text{mH}]$$

$$\Delta L_a = 0 \quad [\text{mH}]$$

$$L_l = 10 \quad [\text{mH}]$$

$$C = 0.25 / 0.5 / 1.0 \quad [\text{mF}]$$

$$R = 10 \quad [\Omega]$$

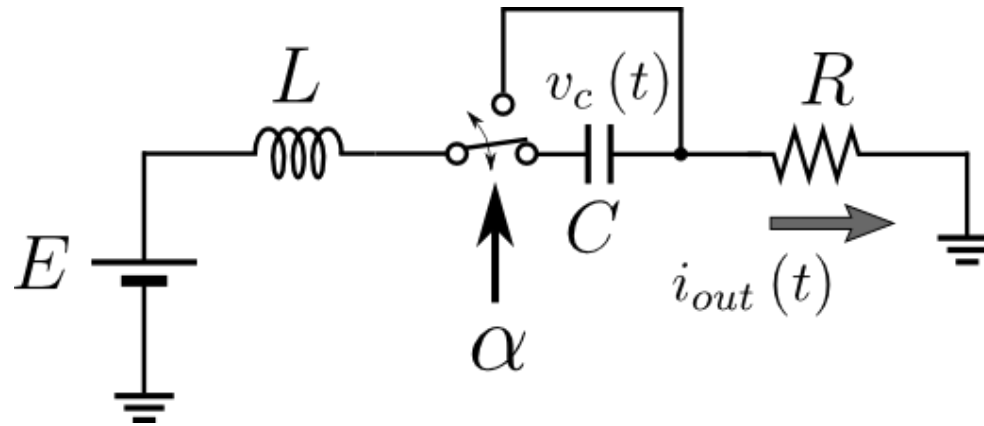
$$r = 0.3 \quad [\Omega]$$

$$f = 50 \quad [\text{Hz}]$$

Performed a transient simulation (LTSpice IV) to check THD.

--- Construction of the models ---

Continuous-time model of test circuit I (1)

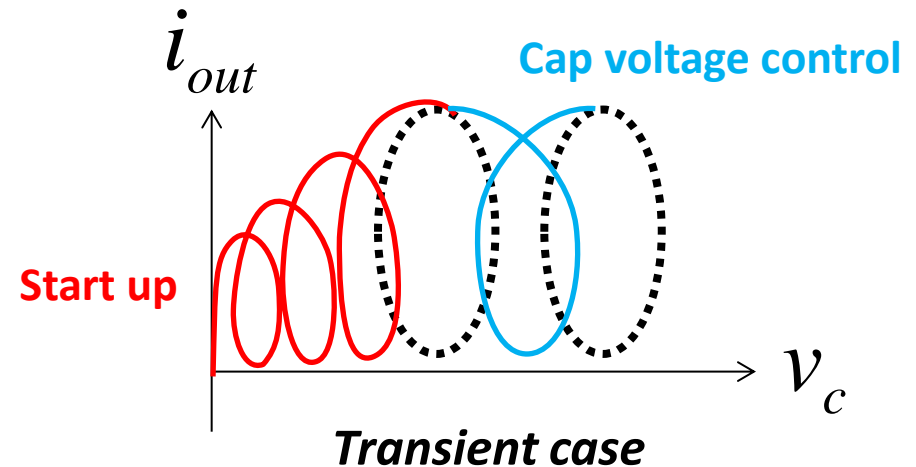
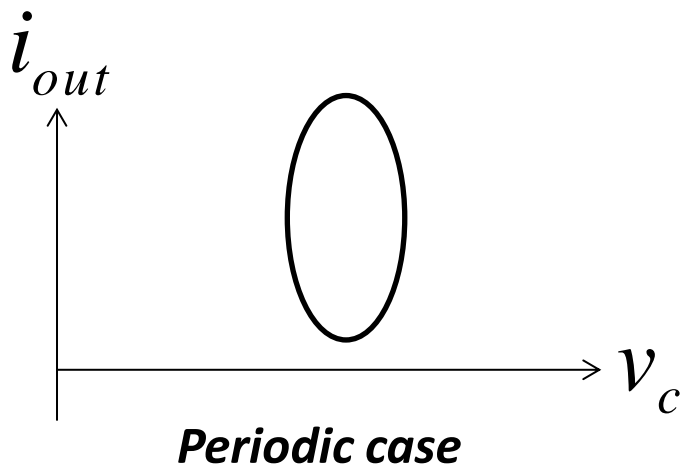


$$\frac{d}{dt} \begin{pmatrix} v_c(t) \\ i_{out}(t) \end{pmatrix} = \begin{pmatrix} \frac{\alpha(t)i_{out}(t)}{C} \\ \frac{1}{L}(E - \alpha(t)v_c(t) - Ri_{out}(t)) \end{pmatrix} = \begin{pmatrix} 0 & \frac{\alpha(t)}{C} \\ -\frac{\alpha(t)}{L} & -\frac{R}{L} \end{pmatrix} \begin{pmatrix} v_c(t) \\ i_{out}(t) \end{pmatrix} + \frac{1}{L} \begin{pmatrix} 0 \\ E \end{pmatrix}$$

The derivatives of the cap voltage and the output current is expressed in a linear formation.

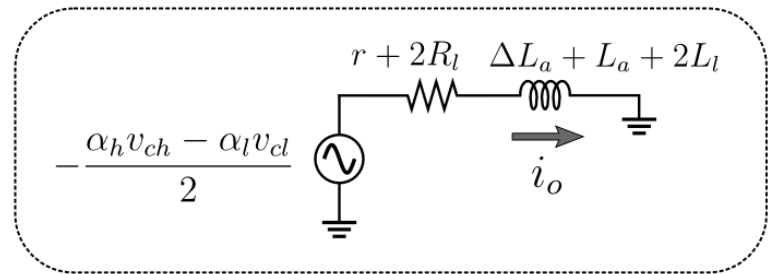
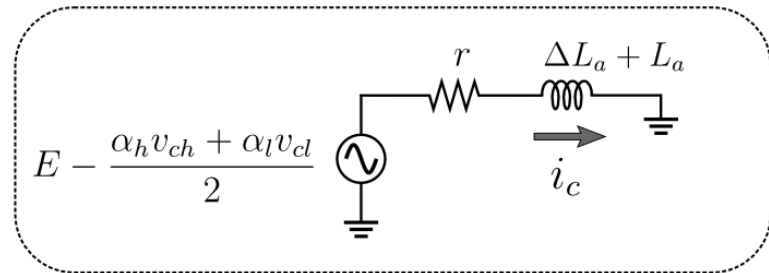
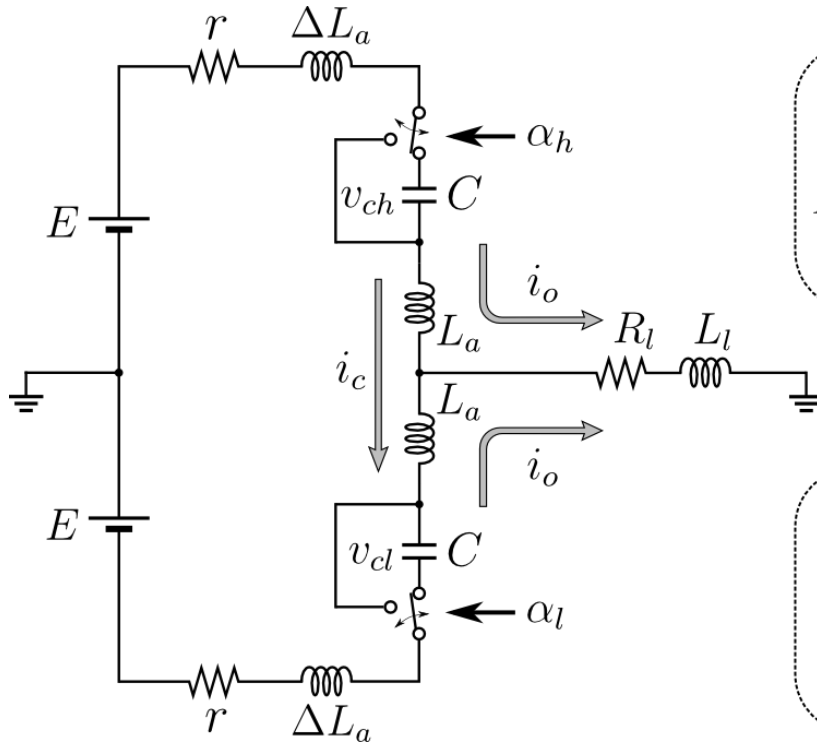
Continuous-time model of test circuit I (2)

$$\frac{d}{dt} \begin{pmatrix} v_c(t) \\ i_{out}(t) \end{pmatrix} = \begin{pmatrix} \frac{\alpha(t)i_{out}(t)}{C} \\ \frac{1}{L}(E - \alpha(t)v_c(t) - Ri_{out}(t)) \end{pmatrix} = \begin{pmatrix} 0 & \frac{\alpha(t)}{C} \\ -\frac{\alpha(t)}{L} & -\frac{R}{L} \end{pmatrix} \begin{pmatrix} v_c(t) \\ i_{out}(t) \end{pmatrix} + \frac{1}{L} \begin{pmatrix} 0 \\ E \end{pmatrix}$$



Phase space is helpful for our intuitive understandings of MMC dynamics.

Continuous-time model of test circuit II (1)



However complicated the circuit would be, the dynamic system can be expressed in linear formation (matrices).

Continuous-time model of test circuit II (2)

$$\frac{d}{dt} \begin{pmatrix} \vec{v}_c(t) \\ \vec{i}(t) \end{pmatrix} = \begin{pmatrix} \frac{\alpha(t)\vec{i}(t)}{C} \\ \mathbf{L}^{-1}(E - \alpha(t)\vec{v}_c(t) - \mathbf{R}\vec{i}(t)) \end{pmatrix} = \begin{pmatrix} 0 & \frac{\alpha(t)}{C} \\ -\mathbf{L}^{-1}\alpha(t) & -\mathbf{L}^{-1}\mathbf{R} \end{pmatrix} \begin{pmatrix} \vec{v}_c(t) \\ \vec{i}(t) \end{pmatrix} + \mathbf{L}^{-1} \begin{pmatrix} \vec{0} \\ \vec{E} \end{pmatrix}$$

$$\vec{v}_c(t) = \begin{pmatrix} v_{ch}(t) \\ v_{cl}(t) \end{pmatrix} \quad \vec{i}(t) = \begin{pmatrix} i_h(t) \\ i_l(t) \end{pmatrix} \quad \vec{E} = \begin{pmatrix} E \\ E \end{pmatrix}$$

$$\mathbf{R} = \begin{pmatrix} r + R & -R \\ -R & r + R \end{pmatrix} \quad \mathbf{L} = \begin{pmatrix} L_a + L_l & -L_l \\ -L_l & L_a + L_l \end{pmatrix} \quad \alpha(t) = \begin{pmatrix} \alpha_h(t) & 0 \\ 0 & \alpha_l(t) \end{pmatrix}$$

It's very similar to the continuous-time model of test circuit I (simple LCR series circuit) !!

--- Details of the iterative algorithm ---

Iterative algorithm for test circuit I (1)

<Fundamental equation of test circuit I >

$$\frac{d}{dt} \begin{pmatrix} v_c(t) \\ i_{out}(t) \end{pmatrix} = \begin{pmatrix} \frac{\alpha(t)i_{out}(t)}{C} \\ \frac{1}{L}(E - \alpha(t)v_c(t) - Ri_{out}(t)) \end{pmatrix} = \begin{pmatrix} 0 & \frac{\alpha(t)}{C} \\ -\frac{\alpha(t)}{L} & -\frac{R}{L} \end{pmatrix} \begin{pmatrix} v_c(t) \\ i_{out}(t) \end{pmatrix} + \frac{1}{L} \begin{pmatrix} 0 \\ E \end{pmatrix}$$

<Fourier transformation >

$$v_c(t) = \sum_{k=-\infty}^{\infty} \tilde{v}_c^{(k)} e^{jk\omega t} \quad i_{out}(t) = \sum_{k=-\infty}^{\infty} \tilde{i}_{out}^{(k)} e^{jk\omega t} \quad \alpha(t) = \sum_{k=-\infty}^{\infty} \tilde{\alpha}^{(k)} e^{jk\omega t}$$

Calculate the Fourier transform of the fundamental equation to find the optimum $\alpha(t)$ for non-distorted $i_{out}(t)$.

Iterative algorithm for test circuit I (2)

< Fundamental equations for non-distorted $i_{out}(t)$ >

$$\tilde{v}_c^{(0)} \tilde{\alpha}^{(k)} + f(\{\tilde{\alpha}^{(n)}\}, \infty, k) = \begin{cases} E - R \tilde{i}_{out}^{(0)} & (k=0) \\ -(j\omega L + R) \tilde{i}_{out}^{(1)} & (k=1) \\ -(-j\omega L + R) \tilde{i}_{out}^{(-1)} & (k=-1) \\ 0 & (|k| \geq 2) \end{cases} \quad \text{Condition 1}$$

$$\tilde{\alpha}^{(0)} \frac{E}{R} = \tilde{v}_c^{(0)} \sum_{k=-\infty}^{\infty} \frac{|\tilde{\alpha}^{(k)}|^2}{jk\omega L + R} + \sum_{k=-\infty}^{\infty} \frac{\tilde{\alpha}^{(-k)}}{jk\omega L + R} f(\{\tilde{\alpha}^{(n)}\}, \infty, k) \quad \text{Condition 2}$$

where

$$f(\{\tilde{\alpha}^{(n)}\}, N, p) = \sum_{m=-N/2}^{-1} \tilde{\alpha}^{(p-m)} \frac{\tilde{i}_{out}^{(0)} \tilde{\alpha}^{(m)} + \tilde{i}_{out}^{(-1)} \tilde{\alpha}^{(m+1)} + \tilde{i}_{out}^{(1)} \tilde{\alpha}^{(m-1)}}{jm\omega C} + \sum_{m=1}^{N/2} \tilde{\alpha}^{(p-m)} \frac{\tilde{i}_{out}^{(0)} \tilde{\alpha}^{(m)} + \tilde{i}_{out}^{(-1)} \tilde{\alpha}^{(m+1)} + \tilde{i}_{out}^{(1)} \tilde{\alpha}^{(m-1)}}{jm\omega C}$$

Iterative algorithm for test circuit I (3)

<Iterative algorithm for test circuit I >

$$\underline{(\tilde{v}_c^{(0)}, \tilde{i}_{out}^{(1)})} \Rightarrow (\tilde{\alpha}^{(0)}, \tilde{\alpha}^{(1)}, \tilde{i}_{out}^{(0)})$$

Input parameters

Initial values

$$\tilde{v}_c^{(0)} \tilde{\alpha}_0^{(k)} = \begin{cases} E - R \tilde{i}_{out}^{(0)} & (k = 0) \\ -(j\omega L + R) \tilde{i}_{out}^{(1)} & (k = 1) \\ -(-j\omega L + R) \tilde{i}_{out}^{(-1)} & (k = -1) \\ 0 & (|k| \geq 2) \end{cases}$$

Equation for the iteration

$$\tilde{v}_c^{(0)} \tilde{\alpha}_{q+1}^{(k)} + f(\{\tilde{\alpha}_q^{(n)}\}, N, k) = \begin{cases} E - R \tilde{i}_{out}^{(0)} & (k = 0) \\ -(j\omega L + R) \tilde{i}_{out}^{(1)} & (k = 1) \\ -(-j\omega L + R) \tilde{i}_{out}^{(-1)} & (k = -1) \\ 0 & (|k| \geq 2) \end{cases}$$

(q+1)'th complex series $\{\tilde{\alpha}_{q+1}^{(n)}\}$ can be obtained by calculating $f(\{\tilde{\alpha}_q^{(n)}\}, N, k)$

Iterative algorithm for test circuit II (1)

<Fundamental equation of test circuit II >

$$\frac{d}{dt} \begin{pmatrix} \vec{v}_c(t) \\ \vec{i}(t) \end{pmatrix} = \begin{pmatrix} \frac{\alpha(t)\vec{i}(t)}{C} \\ \mathbf{L}^{-1}(E - \alpha(t)\vec{v}_c(t) - \mathbf{R}\vec{i}(t)) \end{pmatrix} = \begin{pmatrix} 0 & \frac{\alpha(t)}{C} \\ -\mathbf{L}^{-1}\alpha(t) & -\mathbf{L}^{-1}\mathbf{R} \end{pmatrix} \begin{pmatrix} \vec{v}_c(t) \\ \vec{i}(t) \end{pmatrix} + \mathbf{L}^{-1} \begin{pmatrix} \vec{0} \\ \vec{E} \end{pmatrix}$$


<Fourier transformation >

$$\vec{v}_c(t) = \sum_{k=-\infty}^{\infty} \vec{v}_c^{(k)} e^{jk\omega t} \quad \vec{i}(t) = \sum_{k=-\infty}^{\infty} \vec{i}^{(k)} e^{jk\omega t} \quad \alpha(t) = \sum_{k=-\infty}^{\infty} \alpha^{(k)} e^{jk\omega t}$$

Fourier transform to find the optimum $\alpha(t)$ for non-distorted $\vec{i}_{out}(t)$.

Iterative algorithm for test circuit II (2)

< Iterative algorithm for test circuit II >

$$\underline{\left(\vec{v}_c^{(0)}, \vec{i}_{out}^{(1)} \right)} \Rightarrow \left(\vec{\alpha}^{(0)}, \vec{\alpha}^{(1)}, \vec{i}_{out}^{(0)} \right)$$


Input parameters

Equation for the iteration

Initial values

$$\vec{v}_c^{(0)} \vec{\alpha}_0^{(k)} = \begin{cases} \vec{E} - \mathbf{R} \vec{i}^{(0)} & (k=0) \\ -(j\omega \mathbf{L} + \mathbf{R}) \vec{i}^{(1)} & (k=1) \\ -(-j\omega \mathbf{L} + \mathbf{R}) \vec{i}^{(-1)} & (k=-1) \\ 0 & (|k| \geq 2) \end{cases}$$

$$\vec{v}_c^{(0)} \vec{\alpha}_{q+1}^{(k)} + f(\{\vec{\alpha}_q^{(n)}\}, N, k) = \begin{cases} \vec{E} - \mathbf{R} \vec{i}^{(0)} & (k=0) \\ -(j\omega \mathbf{L} + \mathbf{R}) \vec{i}^{(1)} & (k=1) \\ -(-j\omega \mathbf{L} + \mathbf{R}) \vec{i}^{(-1)} & (k=-1) \\ 0 & (|k| \geq 2) \end{cases}$$

where

$$f(\{\vec{\alpha}^{(n)}\}, N, p) = \sum_{m=-N/2}^{-1} \vec{\alpha}^{(p-m)} \frac{\vec{i}^{(0)} \vec{\alpha}^{(m)} + \vec{i}^{(-1)} \vec{\alpha}^{(m+1)} + \vec{i}^{(1)} \vec{\alpha}^{(m-1)}}{jm\omega C} + \sum_{m=1}^{N/2} \vec{\alpha}^{(p-m)} \frac{\vec{i}^{(0)} \vec{\alpha}^{(m)} + \vec{i}^{(-1)} \vec{\alpha}^{(m+1)} + \vec{i}^{(1)} \vec{\alpha}^{(m-1)}}{jm\omega C}$$

--- Simulation results ---

Simulation results of test circuit I (1)

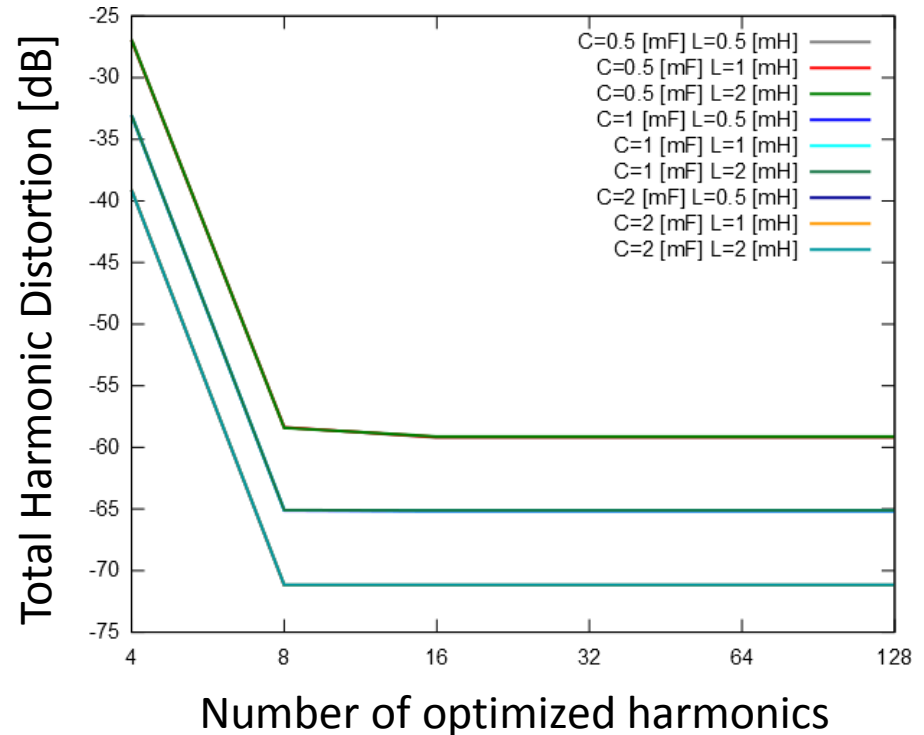
<THD vs # of harmonics>

$$L = 0.5 / 1.0 / 2.0 \quad [\text{mH}]$$

$$C = 0.5 / 1.0 / 2.0 \quad [\text{mF}]$$

$$\tilde{v}_c^{(0)} = 130 \quad [\text{V}]$$

$$I^{(1)} = 2.5 \quad [\text{A}]$$



We have only to optimize 8-16 harmonics in control signals to achieve sufficient THD performance.

Simulation results of test circuit I (2)

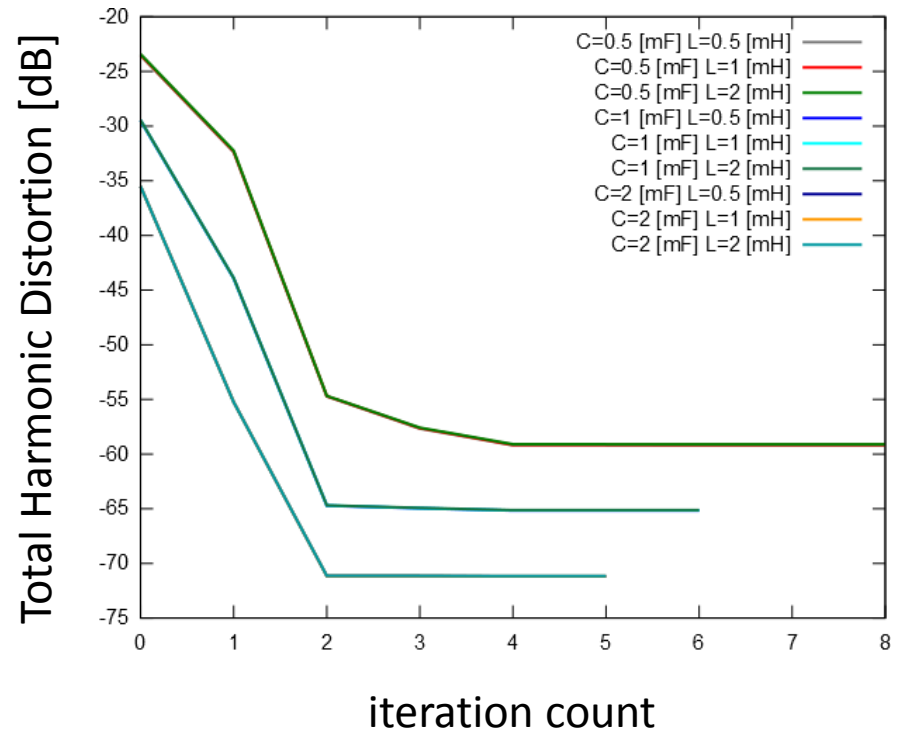
<THD vs iteration count>

$L = 0.5 / 1.0 / 2.0$ [mH]

$C = 0.5 / 1.0 / 2.0$ [mF]

$\tilde{v}_c^{(0)} = 130$ [V]

$I^{(1)} = 2.5$ [A]



- Required iteration count is less than 8 in typical design.
- Less capacitance tends to need more iteration counts.

Simulation results of test circuit I (3)

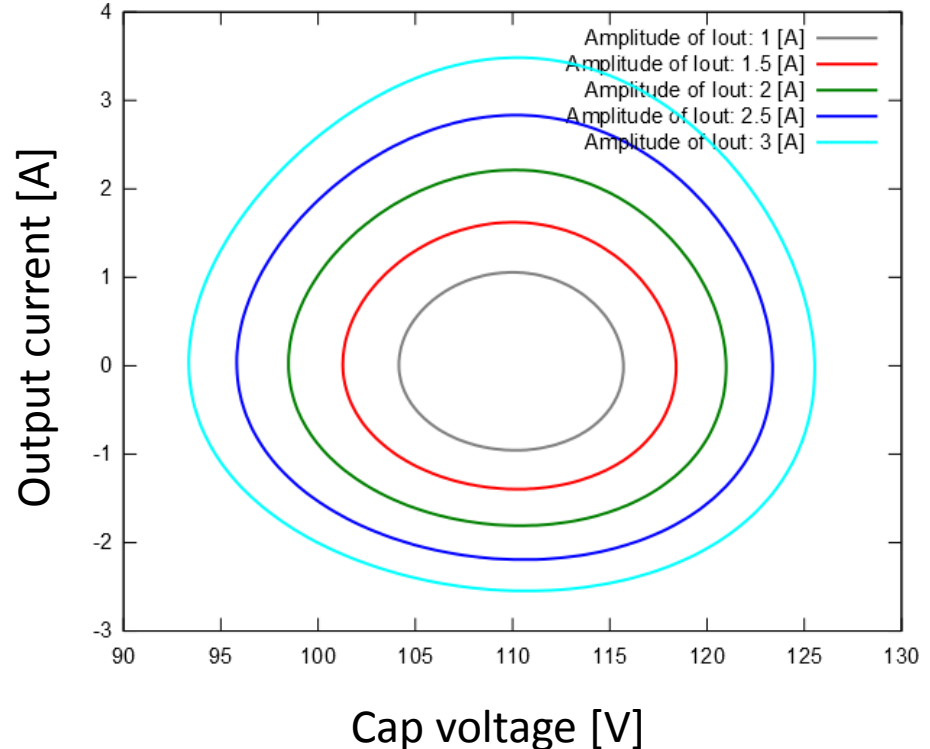
<dependence on $I^{(1)}$ >

$$L = 2.0 \quad [\text{mH}]$$

$$C = 0.5 \quad [\text{mF}]$$

$$\tilde{V}_c^{(0)} = 110 \quad [\text{V}]$$

$$I^{(1)} = 1.0 / 1.5 / 2.0 / \\ 2.5 / 3.0 \quad [\text{A}]$$



- Trajectories for 5 different output currents.
- Applicable to power controls without any degradation of THD.

Simulation results of test circuit I (4)

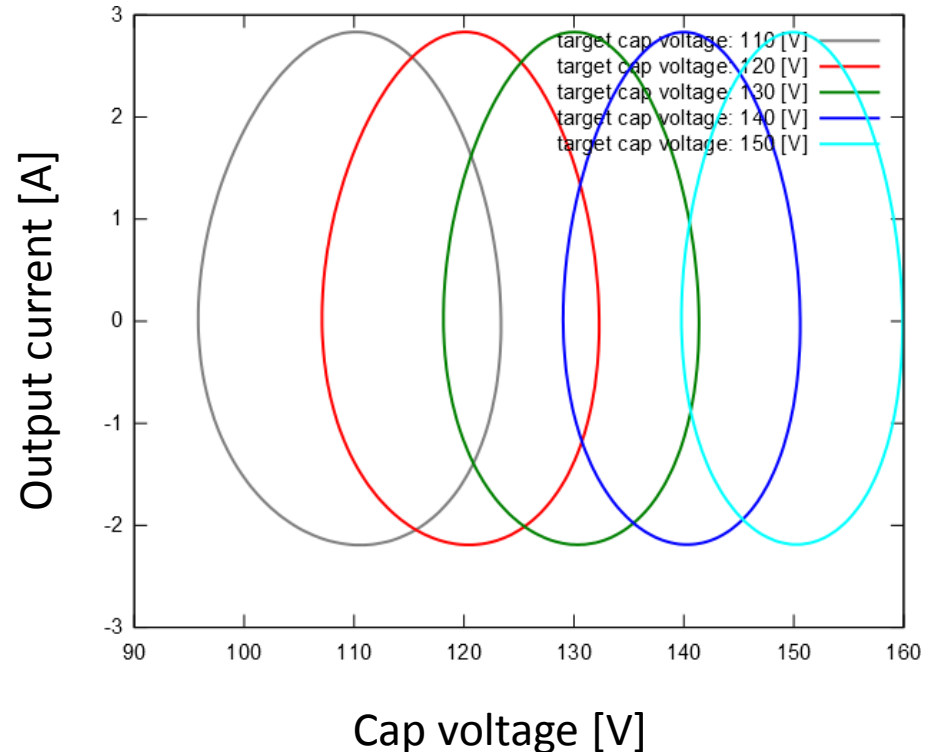
<dependence on $\tilde{v}_c^{(0)}$ >

$$L = 2.0 \quad [\text{mH}]$$

$$C = 0.5 \quad [\text{mF}]$$

$$I^{(1)} = 2.5 \quad [\text{A}]$$

$$\tilde{v}_c^{(0)} = 110 / 120 / 130 \\ / 140 / 150 \quad [\text{V}]$$



- Trajectories for 5 different cap voltages.
- Applicable to cap voltage recovery (restart/mode-switch) without any degradation of THD.

Simulation results of test circuit II (1)

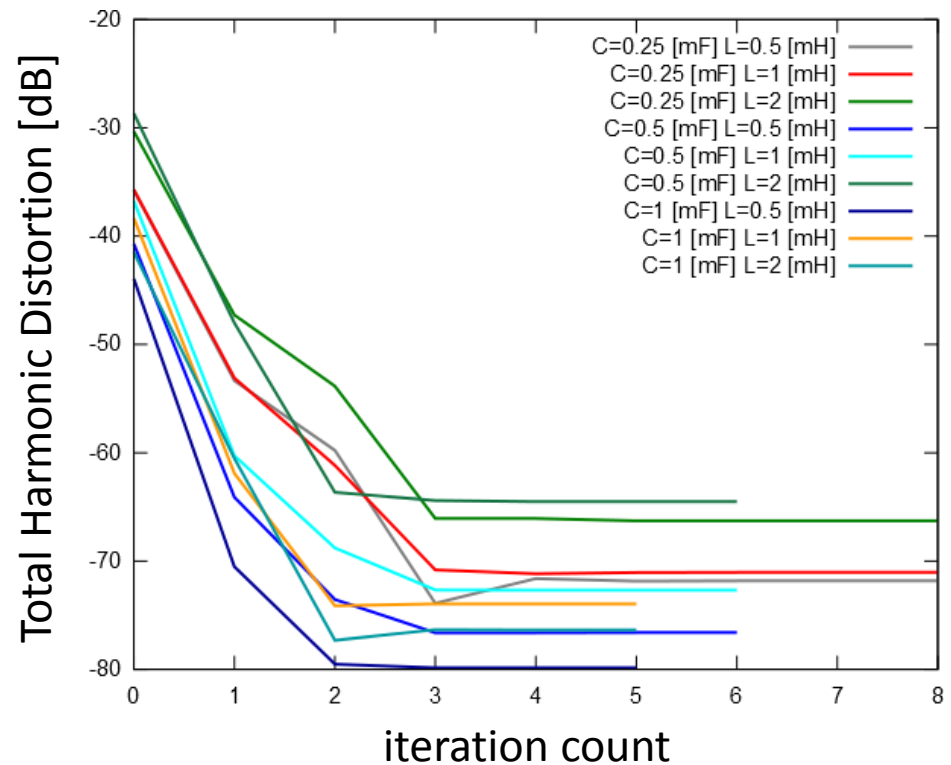
<THD vs iteration count>

$$L_a = 0.5 / 1.0 / 2.0 \quad [\text{mH}]$$

$$C = 0.5 / 1.0 / 2.0 \quad [\text{mF}]$$

$$\tilde{v}_{ch}^{(0)} = \tilde{v}_{cl}^{(0)} = 150 \quad [\text{V}]$$

$$I^{(1)} = 4 \quad [\text{A}]$$



- Required iteration count is less than 8 in typical design.
- Test circuit II exhibits better THD results compared to test circuit I with the same cap values.

Simulation results of test circuit II (2)

<Spice simulation (1) – test bench – >

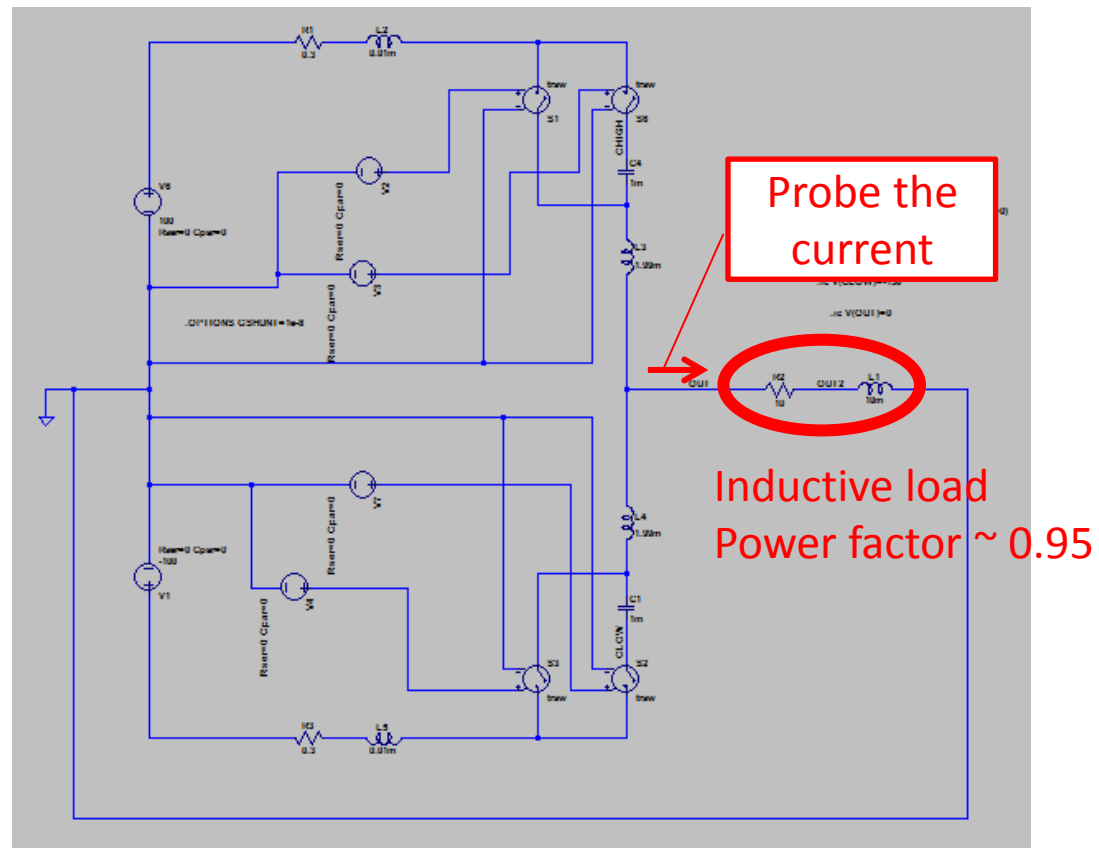
- Half bridge MMC inverter
- One cap for each arm for simplicity
- Switching freq: 12.8[kHz]
- PWM resolution: 100 [ns]
- Control signals @ 7'th iteration

$$L_a = 2.0 \quad [\text{mH}]$$

$$C = 0.25 \quad [\text{mF}]$$

$$\tilde{v}_{ch}^{(0)} = \tilde{v}_{cl}^{(0)} = 200 \quad [\text{V}]$$

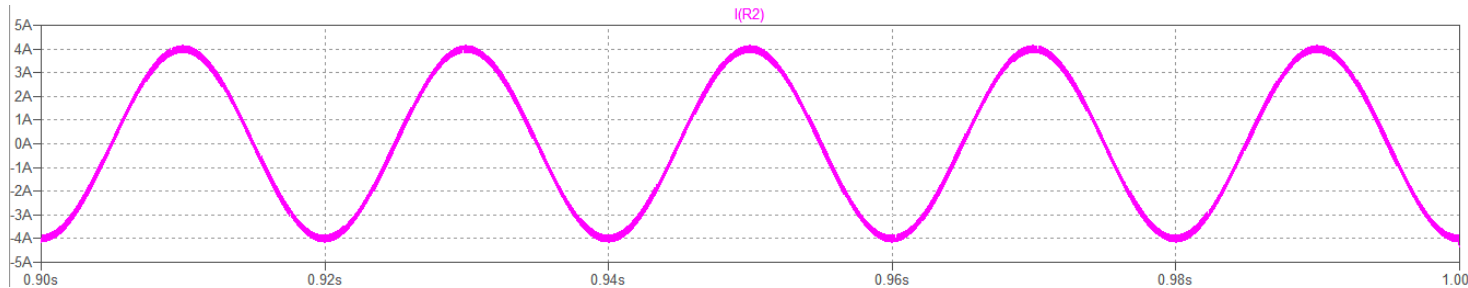
$$I^{(1)} = 4 \quad [\text{A}]$$



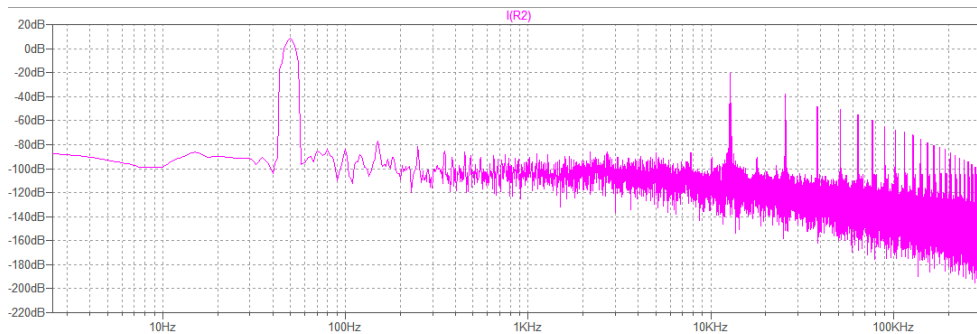
Simulation results of test circuit II (3)

<Spice simulation (2) – output current – >

[transient waveform of the output current]



[FFT result of the output current]

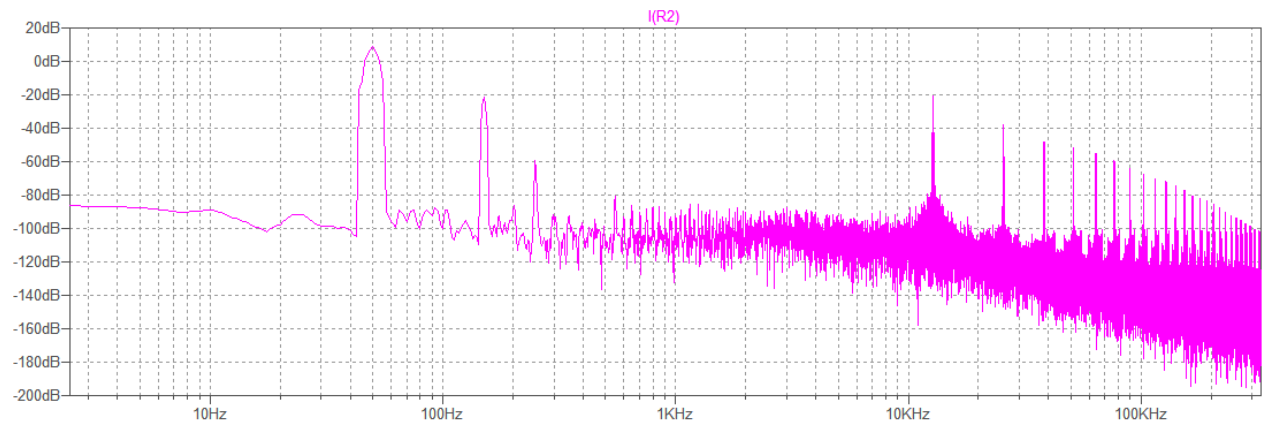


- No spurious @ $50 * n$ [Hz]
- Carrier leakage @ $12.8 * n$ [kHz]
- THD is less than -80 [dB]

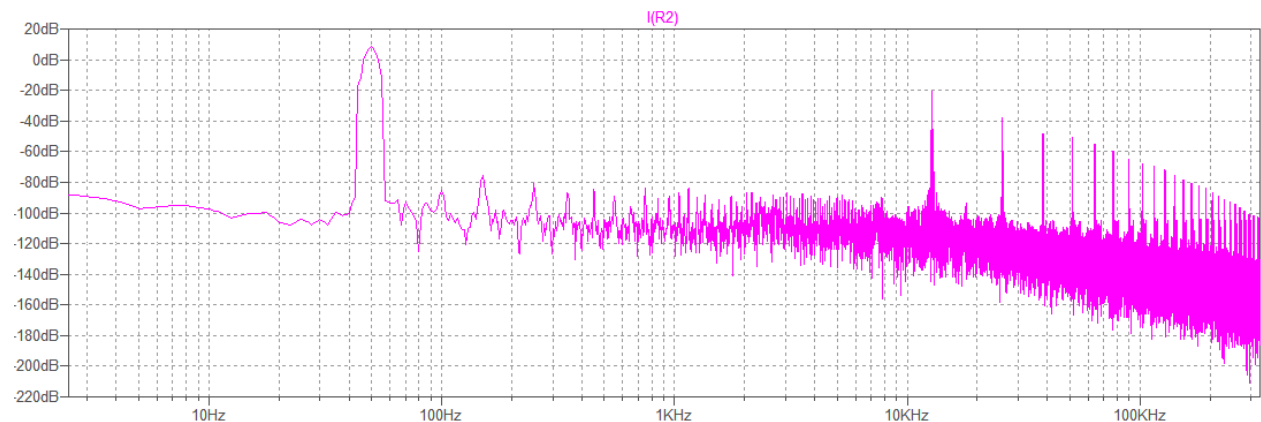
Simulation results of test circuit II (3)

<Spice simulation (3) – Before/After the correction– >

Iteration count:0
THD: -30.5 [dB]



Iteration count:3
THD: -79.0 [dB]



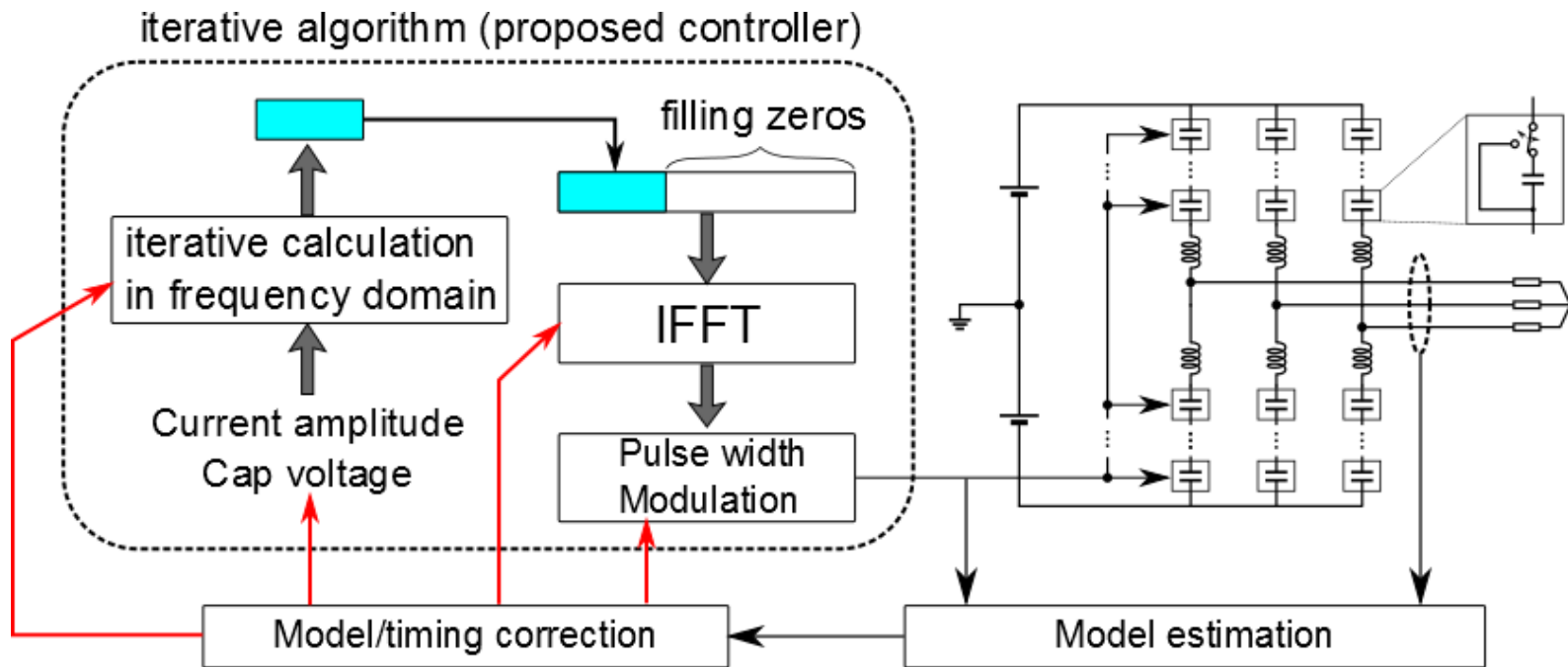
Summary

- THD has been drastically reduced by adjusting a few harmonics in control signals.
- An iterative method has been found to be an effective approach to get numerical solutions of our complicated equations as fast as possible.
- This approach is applicable to any optimization in periodic controls.

--- Future prospects ---

Future prospects (1)

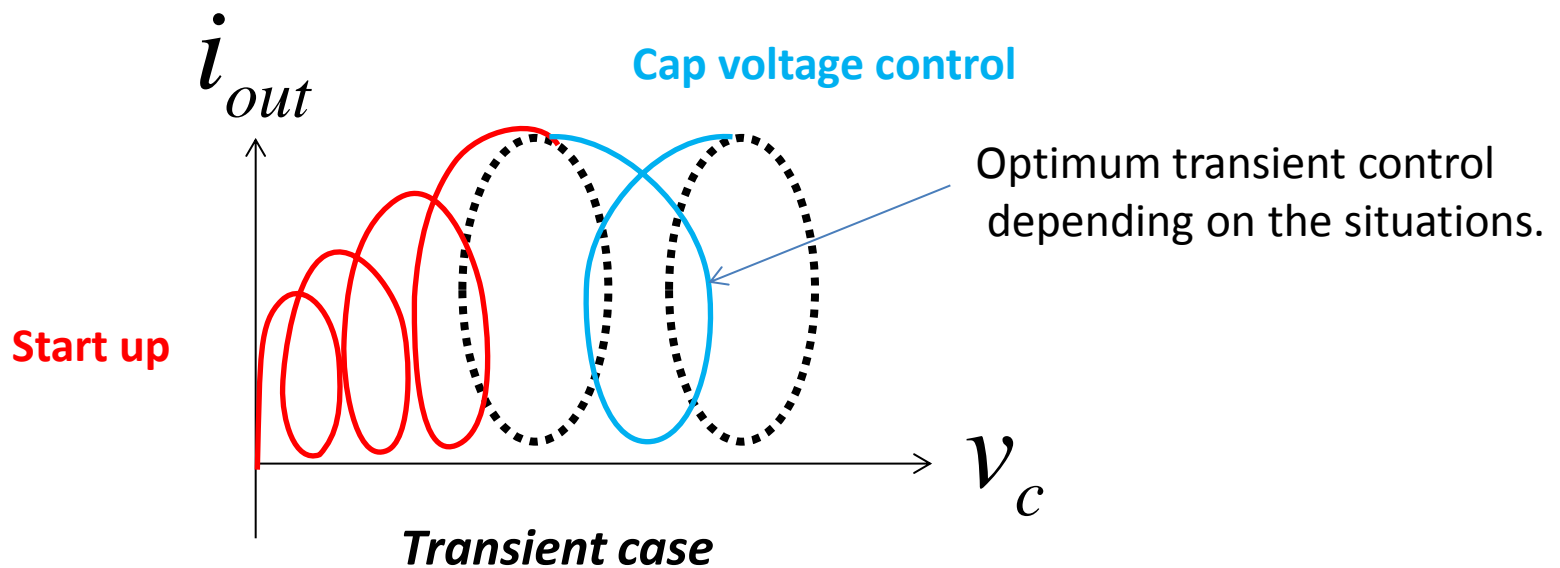
<Periodic control>



- Optimization of control signals including any non-ideal effects.
- For example, skew/device mismatch/dead time/clock feed through /non-linear load,,etc

Future prospects (2)

<Transient control>



- Optimization of evaluation functions in transient controls.
- For example, quick start-up/mode-switch/silent recovery from accidents.

Future prospects (3)

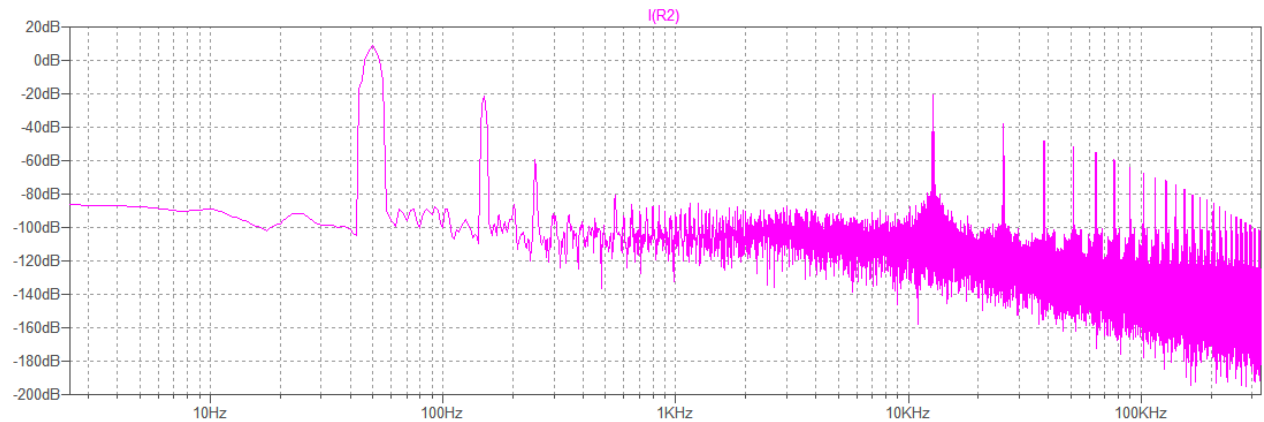
- Optimization of other characteristics of MMCs in periodic/transient operations.
- Proposals of Digital controllers estimating and correcting any conceivable non-ideal factors in analog portions.
- Comprehensive studies on controls of various inverters/converters in periodic/transient operations.

--- Appendix ---

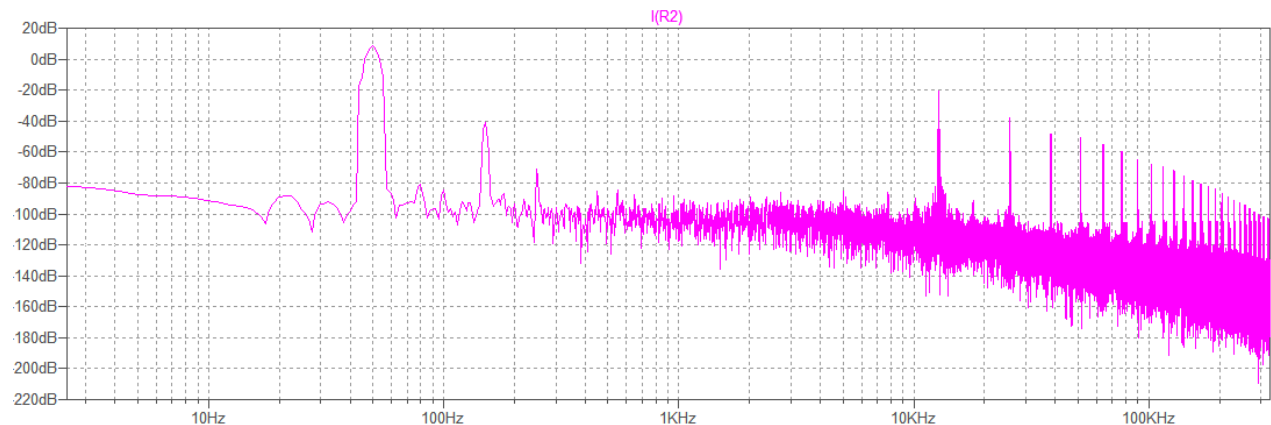
Simulation results of test circuit II

<Spice simulation of test circuit II – FFT results (1) – >

Iteration count:0
THD: -30.5 [dB]



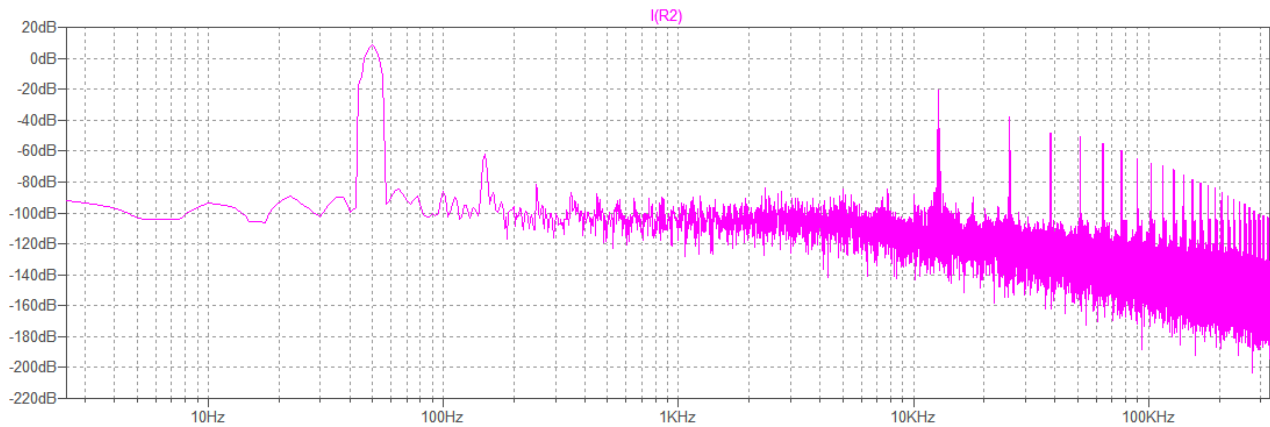
Iteration count:1
THD: -50.2 [dB]



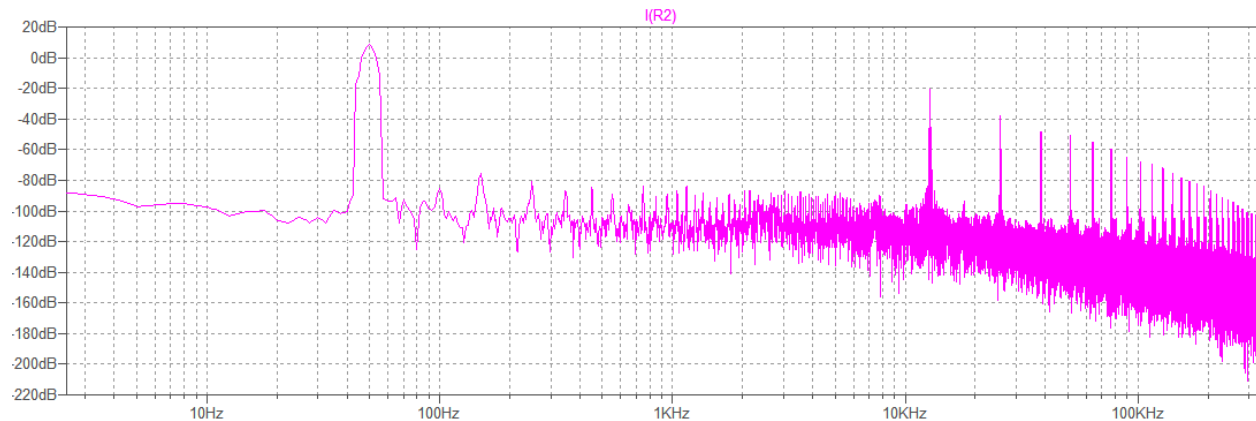
Simulation results of test circuit II

<Spice simulation of test circuit II – FFT results (2) – >

Iteration count:2
THD: -70.8 [dB]



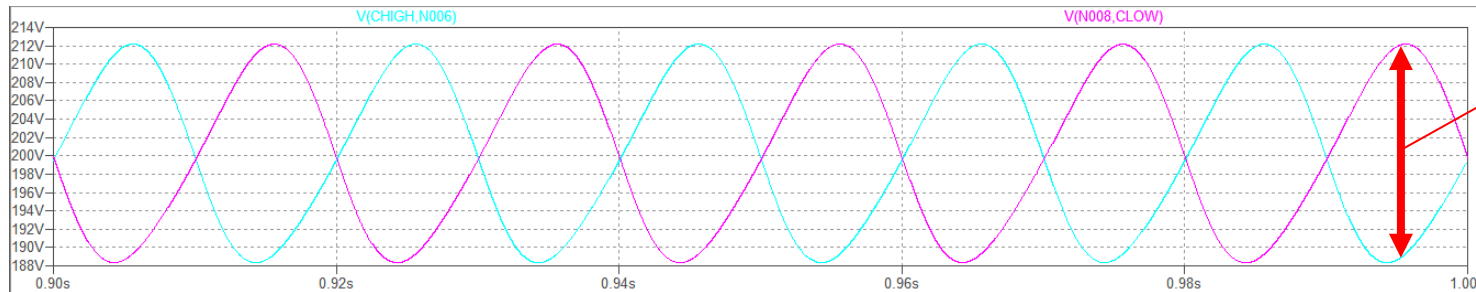
Iteration count:3
THD: -79.0 [dB]



Simulation results of test circuit II

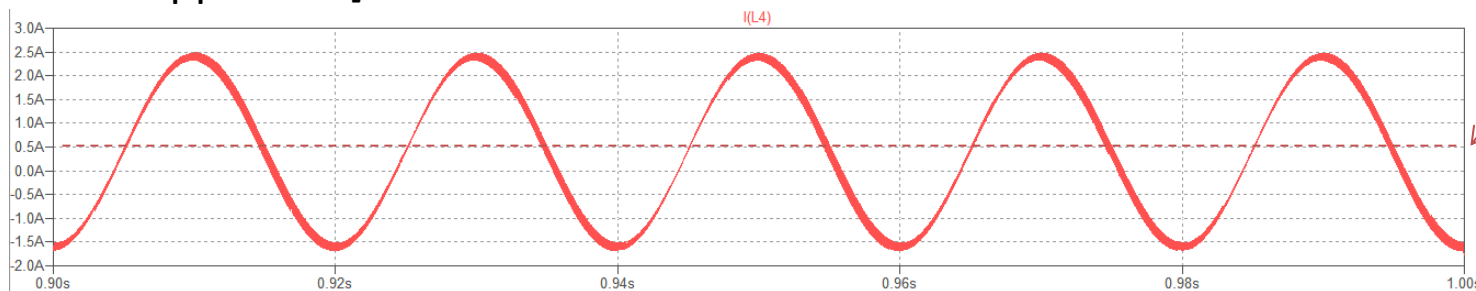
<Spice simulation of test circuit II – Cap voltages – >

[Cap voltages]



~24 [V]

[Current in upper arm]



Circulation
Current

~0.5 [A]